

**Search Notes**

Application/Control No.

10/689,790

Examiner

Seung H. Lee

Applicant(s)/Patent under  
Reexamination

WALKER ET AL.

Art Unit

2876

**SEARCHED**

Class	Subclass	Date	Examiner
235	378	9/16/2006	SHL
705	16	9/16/2006	SHL

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
Same as	Above	9/16/2006	SHL

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
235/375,383,385 (see printouts)	9/16/2006	SHL
705/14(see printouts)	9/16/2006	SHL
09/659752 and cited arts	9/16/2006	SHL
PCT cite	9/16/2006	SHL